Search Notes



Applica	tion/Contro	l No.

Applicant(s)/Patent under Reexamination

10/517,360

Examiner

Phuongchi Nguyen

NAKANO ET AL.

Art Unit

2833

SEARCHED				
Class	Subclass	Date	Examiner	
439	417	2/27/2006	С	
439	499	2/27/2006	С	
439	404	2/27/2006	С	
439	405	2/27/2006	С	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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